

Notice of References Cited	Application/Control No. 10/085,776		Applicant(s)/Patent Under Reexamination CHOI ET AL.	
	Examiner Salman Ahmed		Art Unit 2666	Page 1 of 1

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*	E	US-2001/0026543	10-2001	Hwang et al.	370/335
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NON-PATENT DOCUMENTS

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	U	TSG-RAN Working Group1 meeting #7 TSGR1#7(99)D69 Hanover, Germany, August 30 – September 3, 1999 Agenda Item: Ad Hoc 4 Report and Text Proposal Source: Samsung Electronics Co. Ltd TFCl coding for FDD (rev. of R1-99b61)
	V	TSG-RAN Working Group 1 meeting #5 TSGR(99)913 Helsinki, Finland July 13-16, 1999 Agenda item: Source: Samsung Harmonization impact on TFCl and New Optimal Coding for extended TFCl with almost no Complexity increase
	W	TSG-RAN Working Group 1 meeting #7 TSGR1#7(99)99b60 Hanover, Germany August 30 – September 3, 1999 Agenda item: Source: Samsung New Optimal Coding for extended TFCl with almost no Complexity
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.